WEST Search History

| Hide Items | Restore | Clear | Cancel |

DATE: Wednesday, June 07, 2006

Hide?	Set Name	Query	Hit Count
		DB=PGPB,USPT; PLUR=YES; OP=OR	
□	L38	"scan chain" and (fail$ near2 (population or probabilit$))	30
□	L37	L36 not l35	136
□	L36	"scan chain" and (process near2 (variation or integrity))	150
□	L35	"scan chain" same (process near2 (variation or integrity))	14
□	L34	"scan chain" same systematic	7
□	L33	"scan chain" with systematic	2
□	L32	l13 and l19	31
□	L31	(latch or latches) and "process integrity"	30
□	L30	L29 and "scan chain"	6
□	L29	(latch or latches) same "process variation"	294
□	L28	l19 and ((bias$ or constrain$) with routing)	7
□	L27	"scan chain" same layer	71
□	L26	"scan chain" and (layer with restricted)	1
□	L25	l19 and layer	97
□	L24	l19 and "process defect"	3
□	L23	l21 and L22	38
□	L22	(latch or latches) with type	25741
□	L21	"scan chain" with length	340
□	L20	"san chain" with length	0
□	L19	"scan chain" with (latch or latches)	543
□	L18	l15 not l17	29
□	L17	L16	14
□	L16	"scan chain" same ((cluster$ or group$ or partition$) with (fail or failure))	14
□	L15	"scan chain" same cluster$	33
□	L14	l12 and L13	53
□	L13	"scan chain" and ((place or placing or placement) with (route or routing))	267
□	L12	"scan chain" same model	176
□	L11	l9 not l8	44
□	L10	l8 or L9	128
□	L9	(scan near2 design$) same yield	65
□	L8	"scan chain" same yield	84

☐	L7	"scan chain" and (process near2 (defect or failure))	65
☐	L6	"scan chain" same (process near2 (defect or failure))	10
☐	L5	"scan chain" and ((fabrication or process) near2 sensitivi$)	7
☐	L4	"scan chain" same ((fabrication or process) near2 sensitivi$)	1
☐	L3	l1 or L2	46081
☐	L2	714/$[ccls]	36408
☐	L1	716/$[ccls]	10125

END OF SEARCH HISTORY